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What is "Embedded - Microcontrollers"?

"Embedded - Microcontrollers" refer to small, integrated circuits designed to perform specific tasks within larger systems. These microcontrollers are essentially compact computers on a single chip, containing a processor core, memory, and programmable input/output peripherals. They are called "embedded" because they are embedded within electronic devices to control various functions, rather than serving as standalone computers. Microcontrollers are crucial in modern electronics, providing the intelligence and control needed for a wide range of applications.

Applications of "Embedded - Microcontrollers"

Details	
Product Status	Obsolete
Core Processor	ARM7®
Core Size	32-Bit Single-Core
Speed	60MHz
Connectivity	CANbus, I²C, SPI, SSI, SSP, UART/USART, USB
Peripherals	DMA, PWM, WDT
Number of I/O	72
Program Memory Size	256KB (256K x 8)
Program Memory Type	FLASH
EEPROM Size	-
RAM Size	16K x 8
Voltage - Supply (Vcc/Vdd)	3V ~ 5.5V
Data Converters	A/D 16x10b
Oscillator Type	Internal
Operating Temperature	-40°C ~ 85°C (TA)
Mounting Type	Surface Mount
Package / Case	100-LQFP
Supplier Device Package	-
Purchase URL	https://www.e-xfl.com/product-detail/stmicroelectronics/str750fv2t6

1 Description

The STR750 family of 32-bit microcontrollers combines the industry-standard ARM7TDMI® 32-bit RISC core, featuring high performance, very low power, and very dense code, with a comprehensive set of peripherals and ST's latest 0.18µ embedded Flash technology. The STR750 family comprises a range of devices integrating a common set of peripherals as well as USB, CAN and some key innovations like clock failure detection and an advanced motor control timer. It supports both 3.3V and 5V, and it is also available in an extended temperature range (-40 to +105°C). This makes it a genuine general purpose microcontroller family, suitable for a wide range of applications:

- Appliances, brushless motor drives
- USB peripherals, UPS, alarm systems
- Programmable logic controllers, circuit breakers, inverters
- Medical and portable equipment

2 Device overview

Table 2. Device overview

Features	STR755FR0 STR755FR1 STR755FR2	STR751FR0/ STR751FR1/ STR751FR2	STR752FR0/ STR752FR1/ STR752FR2	STR755FV0 STR755FV1/ STR755FV2	STR750FV0/ STR750FV1/ STR750FV2
Flash - Bank 0 (bytes)	64K/128K/256K				
Flash - Bank 1 (bytes)	16K RWW				
RAM (bytes)	16K				
Operating Temperature.	Ambient temp.:-40 to +85°C / -40 to +105°C (see *Table 49*) Junction temp. -40 to + 125 °C (see *Table 10*)				
Common Peripherals	3 UARTs, 2 SSPs, 1 I2C, 3 timers 1 PWM timer, 38 I/Os 13 Wake-up lines, 11 A/D Channels			3 UARTs, 2 SSPs, 1 I^2C, 3 timers 1 PWM timer, 72 I/Os 15 Wake-up lines, 16 A/D Channels	
USB/CAN peripherals	None	USB	CAN	None	USB+CAN
Operating Voltage	3.3V or 5V	3.3V	3.3V or 5V		
Packages (**x**)	**T**=LQFP64 10x10, **H**=LFBGA64			**T**=LQFP100 14x14, **H**=LFBGA100	

periodic interrupt. It is clocked by an external 32.768 kHz oscillator or the internal low power RC oscillator. The RC has a typical frequency of 300 kHz and can be calibrated.

WDG (watchdog timer)

The watchdog timer is based on a 16-bit downcounter and 8-bit prescaler. It can be used as watchdog to reset the device when a problem occurs, or as free running timer for application time out management.

Timebase timer (TB)

The timebase timer is based on a 16-bit auto-reload counter and not connected to the I/O pins. It can be used for software triggering, or to implement the scheduler of a real-time operating system.

Synchronizable standard timers (TIM2:0)

The three standard timers are based on a 16-bit auto-reload counter and feature up to 2 input captures and 2 output compares (for external triggering or time base / time out management). They can work together with the PWM timer via the Timer Link feature for synchronization or event chaining. In reset state, timer Alternate Function I/Os are connected to the same
I/O ports in both 64-pin and 100-pin devices. To optimize timer functions in 64-pin devices, timer Alternate Function I/Os can be connected, or “remapped”, to other I/O ports as summarized in *Table 3* and detailed in *Table 6*. This remapping is done by the application via a control register.

Table 3. Standard timer alternate function I/Os

Standard timer functions		Number of alternate function I/Os		
		100-pin package	64-pin package	
			Default mapping	Remapped
TIM 0	Input Capture	2	1	2
	Output Compare/PWM	2	1	2
TIM 1	Input Capture	2	1	1
	Output Compare/PWM	2	1	1
TIM 2	Input Capture	2	2	2
	Output Compare/PWM	2	1	2

Any of the standard timers can be used to generate PWM outputs. One timer (TIM0) is mapped to a DMA channel.

Motor control PWM timer (PWM)

The Motor Control PWM Timer (PWM) can be seen as a three-phase PWM multiplexed on 6 channels. The 16-bit PWM generator has full modulation capability (0...100%), edge or centre-aligned patterns and supports dead-time insertion. It has many features in common with the standard TIM timers which has the same architecture and it can work together with the TIM timers via the Timer Link feature for synchronization or event chaining.The PWM timer is mapped to a DMA channel.

I²C bus

The I²C bus interface can operate in multi-master and slave mode. It can support standard and fast modes (up to 400KHz).

High speed universal asynch. receiver transmitter (UART)

The three UART interfaces are able to communicate at speeds of up to 2 Mbit/s. They provide hardware management of the CTS and RTS signals and have LIN Master capability.

To optimize the data transfer between the processor and the peripheral, two FIFOs (receive/transmit) of 16 bytes each have been implemented.

One UART can be served by the DMA controller (UART0).

Synchronous serial peripheral (SSP)

The two SSPs are able to communicate up to 8 Mbit/s (SSP1) or up to 16 Mbit/s (SSP0) in standard full duplex 4-pin interface mode as a master device or up to 2.66 Mbit/s as a slave device. To optimize the data transfer between the processor and the peripheral, two FIFOs (receive/transmit) of 8 x 16 bit words have been implemented. The SSPs support the Motorola SPI or TI SSI protocols.

One SSP can be served by the DMA controller (SSP0).

Controller area network (CAN)

The CAN is compliant with the specification 2.0 part B (active) with a bit rate up to 1Mbit/s. It can receive and transmit standard frames with 11-bit identifiers as well as extended frames with 29-bit identifiers. Up to 32 message objects are handled through an internal RAM buffer. In LQFP64 devices, CAN and USB cannot be connected simultaneously.

Universal serial bus (USB)

The STR750F embeds a USB device peripheral compatible with the USB Full speed 12Mbs. The USB interface implements a full speed (12 Mbit/s) function interface. It has software configurable endpoint setting and suspend/resume support. The dedicated 48 MHz clock source is generated from the internal main PLL. V_{DD} must be in the range 3.3V±10% for USB operation.

ADC (analog to digital converter)

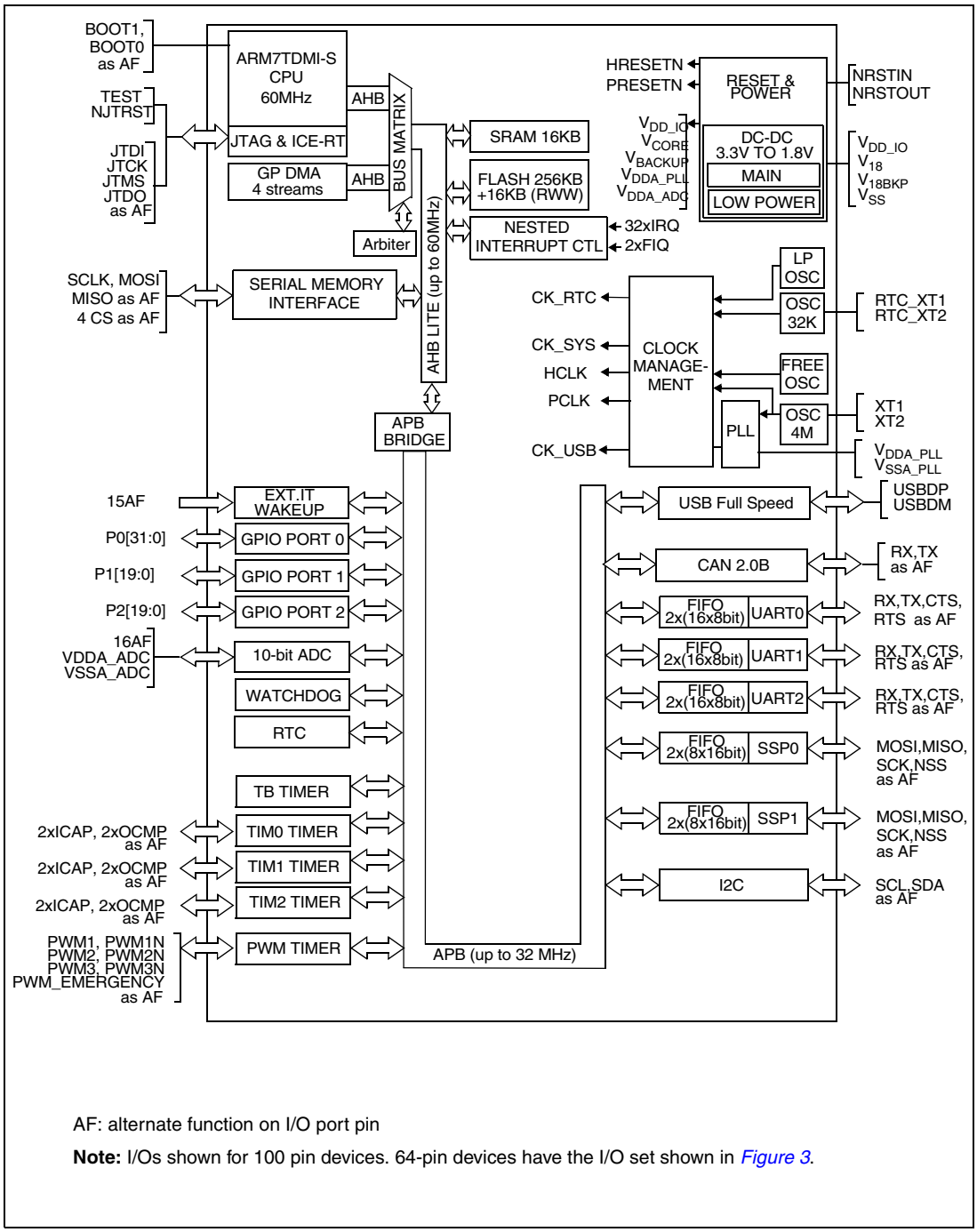
The 10-bit Analog to Digital Converter, converts up to 16 external channels (11 channels in 64-pin devices) in single-shot or scan modes. In scan mode, continuous conversion is performed on a selected group of analog inputs. The minimum conversion time is 3.75 µs (including the sampling time).
The ADC can be served by the DMA controller.

An analog watchdog feature allows you to very precisely monitor the converted voltage of up to four channels. An IRQ is generated when the converted voltage is outside the programmed thresholds.

The events generated by TIM0, TIM2 and PWM timers can be internally connected to the ADC start trigger, injection trigger, and DMA trigger respectively, to allow the application to synchronize A/D conversion and timers.

3.2 Block diagram

Figure 1. STR750 block diagram



AF: alternate function on I/O port pin

Note: I/Os shown for 100 pin devices. 64-pin devices have the I/O set shown in *Figure 3*.

4 Pin description

Figure 2. LQFP100 pinout

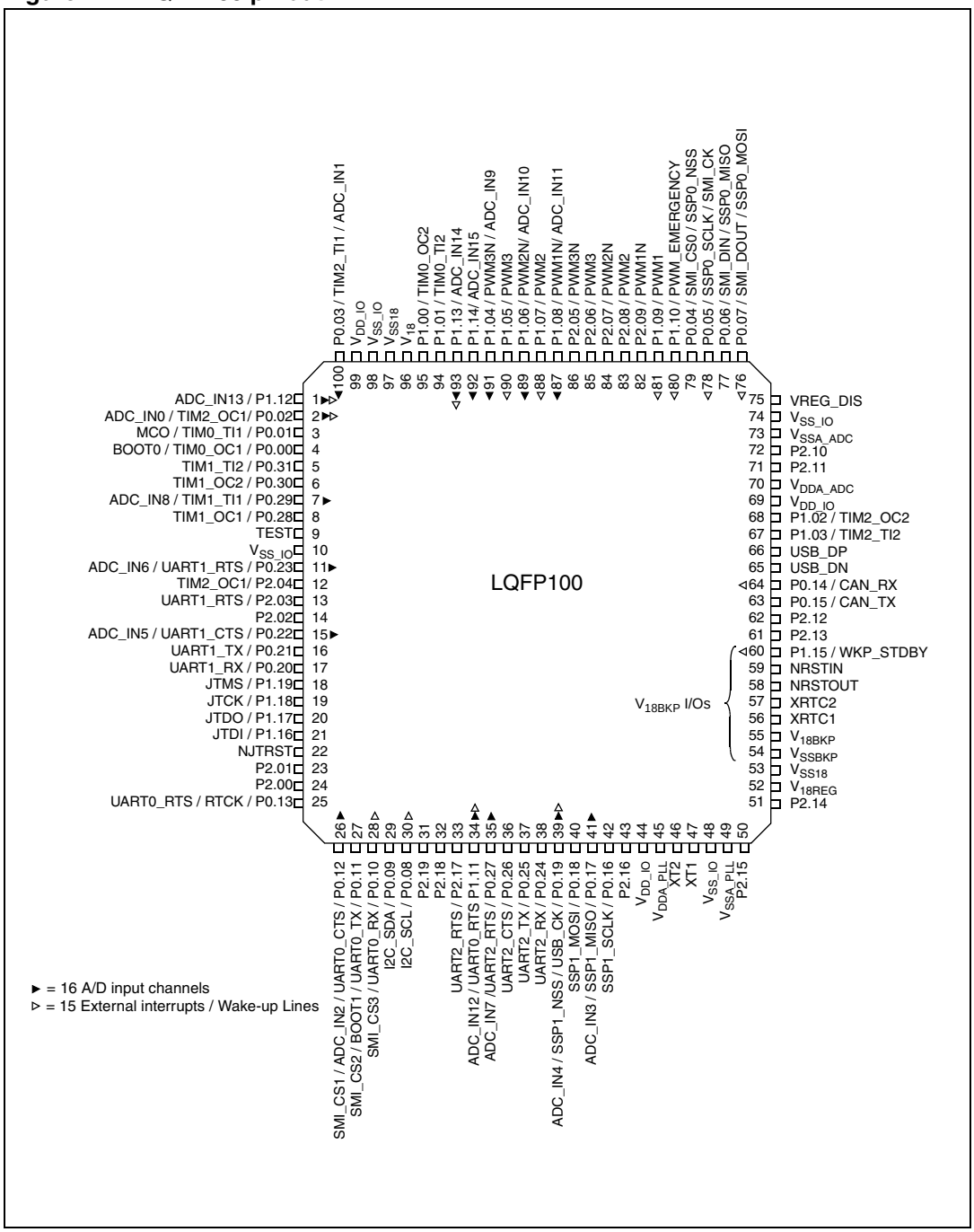


Figure 3. LQFP64 pinout

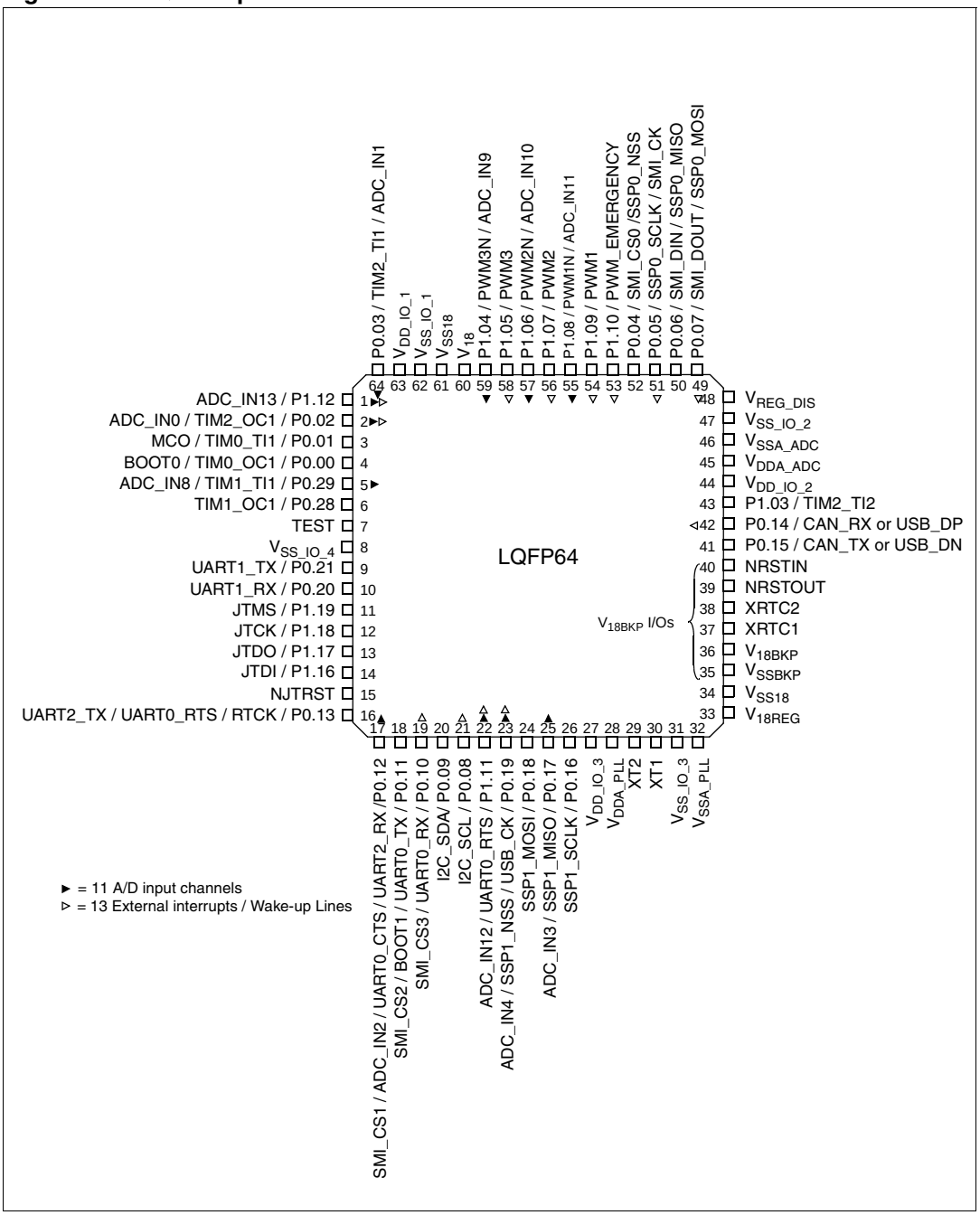


Table 4. LFBGA100 ball connections

	1	2	3	4	5	6	7	8	9	10
A	P0.03	P1.13	P1.14	P1.04	P1.06	P1.08	P0.05	P0.06	P0.07	P1.02
B	P1.12	P0.02	P0.01	P1.05	P1.07	P1.09	P0.04	P2.13	P1.03	P2.10
C	P0.31	P0.00	V_{DD_IO}	V_{18}	P1.10	P2.09	V_{SS_IO}	V_{SSA_ADC}	P2.11	USB_DP
D	P0.29	P0.30	V_{SS_IO}	V_{SS18}	P1.01	P1.15	V_{DD_IO}	V_{DDA_ADC}	P2.12	USB_DN
E	P0.28	P0.23	P0.22	V_{SS_IO}	TEST	P1.00	NRSTOUT	VREG_DIS	NRSTIN	P0.14
F	P2.03	P0.21	P0.20	P2.02	P2.04	P2.05	P2.06	V_{SS18}	V_{SSBKP}	P0.15
G	NJTRST	P1.18	P1.19	P2.01	P2.00	P2.07	2.08	V_{18REG}	V_{18BKP}	XRTC2
H	P0.13	P1.16	P1.17	P2.19	P2.18	P2.17	P0.24	P2.14	P2.16	XRTC1
J	P0.11	P0.12	P1.11	P0.27	P0.19	P0.26	P0.25	P2.15	V_{DD_IO}	V_{SS_IO}
K	P0.10	P0.09	P0.08	P0.18	P0.17	P0.16	XT1	XT2	V_{DDA_PLL}	V_{SSA_PLL}

Table 5. LFBGA64 ball connections

	1	2	3	4	5	6	7	8
A	P0.03	V_{SS_IO}	P1.04	P1.06	P1.08	P0.05	P0.06	P0.07
B	P1.12	V_{DD_IO}	P1.05	P1.07	P1.09	P0.04	P1.10	P1.03
C	P0.01	P0.02	P0.00	V_{18}	V_{SS18}	V_{DD_IO}	V_{SS_IO}	P0.14
D	P0.29	P0.28	TEST	V_{SS_IO}	VREG_DIS	V_{DDA_ADC}	V_{SSA_ADC}	P0.15
E	P1.18	P1.19	P0.20	P0.21	NRSTOUT	NRSTIN	V_{18BKP}	XRTC2
F	P0.13	NJTRST	P1.16	P1.17	V_{18REG}	V_{SS18}	V_{SSBKP}	XRTC1
G	P0.11	P0.12	P1.11	P0.19	V_{DD_IO}	V_{SS_IO}	V_{DDA_PLL}	V_{SSA_PLL}
H	P0.10	P0.09	P0.08	P0.17	P0.18	P0.16	XT2	XT1

Table 6. STR750F pin description (continued)

Pin n°				Pin name	Type	Input				Output			Usable in Standby	Main function (after reset)	Alternate function	
LQFP100(1)	LFBGA100(1)	LQFP64(2)	LFBGA64(2)			Input Level	floating	pu/pd	Ext. int /Wake-up	Capability	OD (3)	PP				
7	D1	5	D1	P0.29 / TIM1_TI1 / ADC_IN8	I/O	T_T	**X**	X		O2	X	X		**Port 0.29**	TIM1: Input Capture 1	ADC: Analog input 8
8	E1	6	D2	P0.28 / TIM1_OC1	I/O	T_T	**X**	X		O2	X	X		**Port 0.28**	TIM1: Output Compare 1	
9	E5	7	D3	TEST	I									Reserved, must be tied to ground		
10	E4	8	D4	VSS_IO	S									Ground Voltage for digital I/Os		
11	E2			P0.23 / UART1_RTS / ADC_IN6	I/O	T_T	**X**	X		O2	X	X		**Port 0.23**	UART1: Ready To Send output(4)	ADC analog input 6
12	F5			P2.04 / TIM2_OC1	I/O	T_T	**X**	X		O2	X	X		**Port 2.04**	TIM2: Output Compare 1(4)	
13	F1			P2.03 / UART1_RTS	I/O	T_T	**X**	X		O2	X	X		**Port 2.03**	UART1: Ready To Send output(4)	
14	F4			P2.02	I/O	T_T	**X**	X		O2	X	X		**Port 2.02**		
15	E3			P0.22 / UART1_CTS / ADC_IN5	I/O	T_T	**X**	X		O2	X	X		**Port 0.22**	UART1: Clear To Send input	ADC: Analog input 5
16	F2	9	E4	P0.21 / UART1_TX	I/O	T_T	**X**	X		O2	X	X		**Port 0.21**	UART1: Transmit data output (remappable to P0.15)(4)	
17	F3	10	E3	P0.20 / UART1_RX	I/O	T_T	**X**	X		O2	X	X		**Port 0.20**	UART1: Receive data input (remappable to P0.14)(4)	
18	G3	11	E2	P1.19 / JTMS	I/O	T_T	X	X		O2	X	X		**JTAG mode selection input(6)**	Port 1.19	
19	G2	12	E1	P1.18 / JTCK	I/O	T_T	X	X		O2	X	X		**JTAG clock input(6)**	Port 1.18	
20	H3	13	F4	P1.17 / JTDO	I/O	T_T	X	X		O8	X	X		**JTAG data output(6)**	Port 1.17	
21	H2	14	F3	P1.16 / JTDI	I/O	T_T	X	X		O2	X	X		**JTAG data input(6)**	Port 1.16	
22	G1	15	F2	NJTRST	I	T_T								JTAG reset input(5)		
23	G4			P2.01	I/O	T_T	**X**	X		O2	X	X		**Port 2.01**		
24	G5			P2.00	I/O	T_T	**X**	X		O2	X	X		**Port 2.00**		
25	H1	16	F1	P0.13 / RTCK / UART0_RTS UART2_TX	I/O	T_T	X	X		O8	X	X		**JTAG return clock output(6)**	Port 0.13 / UART0: Ready To Send output(4)	UART2: Transmit Data output (when remapped)(8)

Table 6. STR750F pin description (continued)

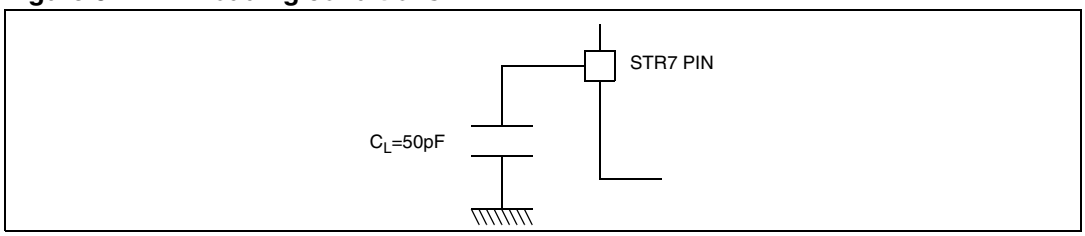
Pin n°				Pin name	Type	Input				Output			Usable in Standby	Main function (after reset)	Alternate function	
LQFP100(1)	LFBGA100(1)	LQFP64(2)	LFBGA64(2)			Input Level	floating	pu/pd	Ext. int /Wake-up	Capability	OD (3)	PP				
91	A4	59	A3	P1.04 / PWM3N / ADC_IN9	I/O	T_T	**X**	X		O4	X	X		**Port 1.04**	PWM: PWM3 complementary output(4)	ADC: analog input 9
92	A3			P1.14 / ADC_IN15	I/O	T_T	**X**	X		O8	X	X		**Port 1.14**	ADC: analog input 15	
93	A2			P1.13 / ADC_IN14	I/O	T_T	**X**	X	EIT13	O8	X	X		**Port 1.13**	ADC: analog input 14	
94	D5			P1.01 / TIM0_TI2	I/O	T_T	**X**	X		O2	X	X		**Port 1.01**	TIM0: Input Capture / trigger / external clock 2 (remappable to P0.05)(8)	
95	E6			P1.00 / TIM0_OC2	I/O	T_T	**X**	X		O2	X	X		**Port 1.00**	TIM0: Output compare 2 (remappable to P0.04)(8)	
96	C4	60	C4	V18	S									Stabilization for main voltage regulator. Requires external capacitors 33nF between V18 and VSS18. See *Figure 4.2*. To be connected to the 1.8V external power supply when embedded regulators are not used.		
97	D4	61	C5	VSS18	S									Ground Voltage for the main voltage regulator.		
98	D3	62	A2	VSS_IO	S									Ground Voltage for digital I/Os		
99	C3	63	B2	VDD_IO	S									Supply Voltage for digital I/Os		
100	A1	64	A1	P0.03 / TIM2_TI1 / ADC_IN1	I/O	T_T	**X**	X		O2	X	X		**Port 0.03**	TIM2: Input Capture / trigger / external clock 1	ADC: analog input 1

1. For STR755FVx part numbers, the USB pins must be left unconnected.
2. The non available pins on LQPFP64 and LFBGA64 packages are internally tied to low level.
3. None of the I/Os are True Open Drain: when configured as Open Drain, there is always a protection diode between the I/O pin and VDD_IO.
4. In the 100-pin package, this Alternate Function is duplicated on two ports. You can configure one port to use this AF, the other port is then free for general purpose I/O (GPIO), external interrupt/wake-up lines, or analog input (ADC_IN) where these functions are listed in the table.
5. It is mandatory that the NJTRST pin is reset to ground during the power-up phase. It is recommended to connect this pin to NRSTOUT pin (if available) or NRSTIN.
6. After reset, these pins are enabled as JTAG alternate function see (*Port reset state on page 16*). To use these ports as general purpose I/O (GPIO), the DBGOFF control bit in the GPIO_REMAP0R register must be set by software (in this case, debugging these I/Os via JTAG is not possible).
7. There are two different TQFP and BGA 64-pin packages: in the first one, pins 41 and 42 are mapped to USB DN/DP while for the second one, they are mapped to P0.15/CAN_TX and P0.14/CAN_RX.
8. For details on remapping these alternate functions, refer to the GPIO_REMAP0R register description.

6.1.4 Loading capacitor

The loading conditions used for pin parameter measurement are shown in *Figure 6*.

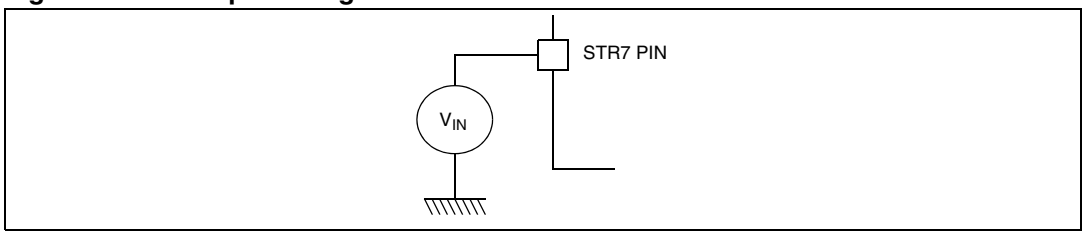
Figure 6. Pin loading conditions



6.1.5 Pin input voltage

The input voltage measurement on a pin of the device is described in *Figure 7*.

Figure 7. Pin input voltage

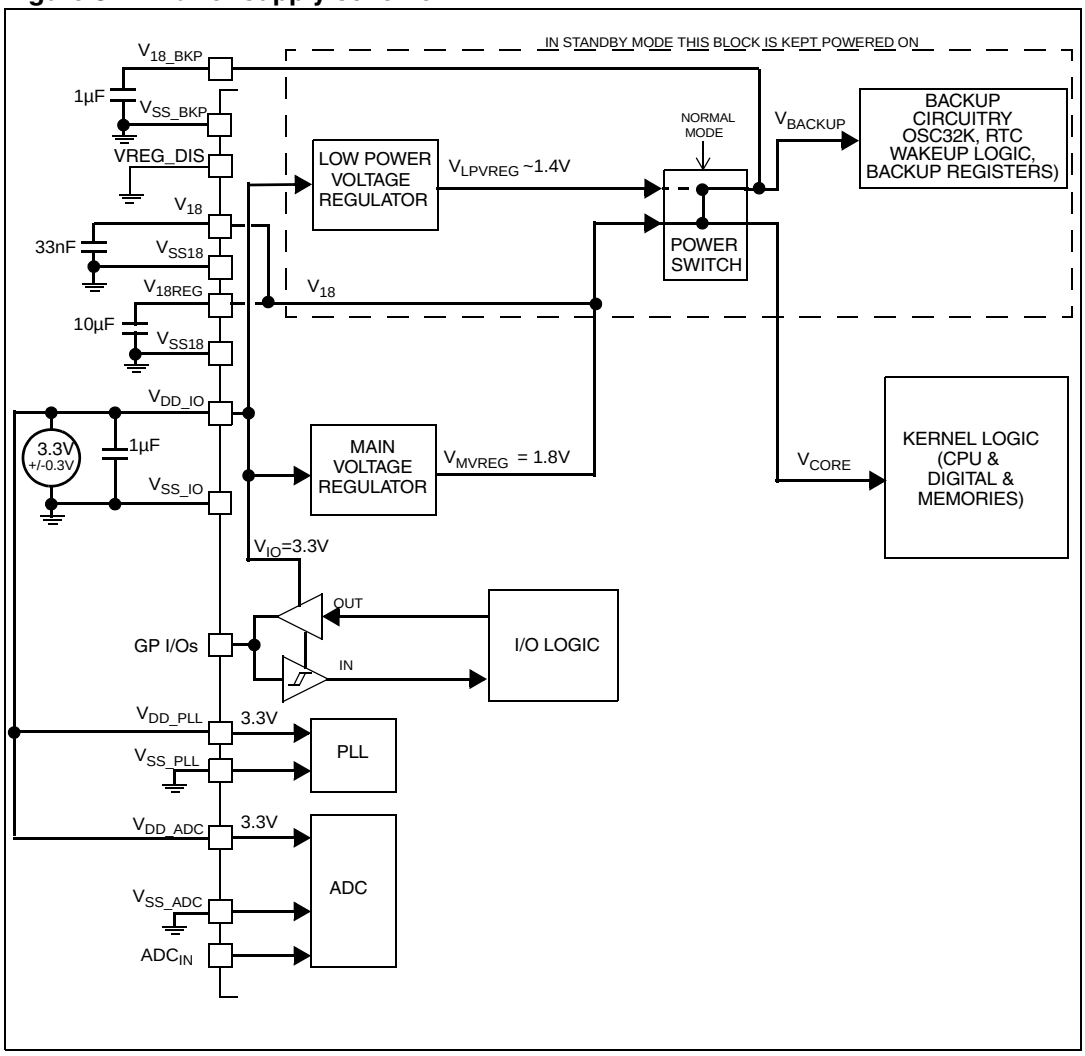


6.1.6 Power supply schemes

When mentioned, some electrical parameters can refer to a dedicated power scheme among the four possibilities. The four different power schemes are described below.

Power supply scheme 1: Single external 3.3 V power source

Figure 8. Power supply scheme 1



6.3.2 Operating conditions at power-up / power-down

Subject to general operating conditions for T_A.

Table 11. Operating conditions at power-up / power-down

Symbol	Parameter	Conditions	Min(1)	Typ	Max(1)	Unit
t_{VDD_IO}	V_{DD_IO} rise time rate		20			µs/V
					20	ms/V
t_{V18}	V_{18} rise time rate (1)	When 1.8 V power is supplied externally	20			µs/V
					20	ms/V

1. Data guaranteed by characterization, not tested in production.

6.3.3 Embedded voltage regulators

Subject to general operating conditions for V_{DD_IO}, and T_A

Table 12. Embedded voltage regulators

Symbol	Parameter	Conditions	Min	Typ	Max	Unit
V_{MVREG}	MVREG power supply(1)	load <150 mA	1.65	1.80	1.95	V
V_{LPVREG}	LPVREG power supply(2)	load <10 mA	1.30	1.40	1.50	V
t_{VREG_PWRUP}(1)	Voltage Regulators start-up time (to reach 90% of final V_{18} value) at V_{DD_IO} power-up(3)	V_{DD_IO} rise slope = 20 µs/V		80		µs
		V_{DD_IO} rise slope = 20 ms/V		35		ms

1. V_{MVREG} is observed on the V_{18}, V_{18REG} and V_{18BKP} pins except in the following case:
   - In STOP mode with MVREG OFF (LP_PARAM13 bit). See note 2.
   - In STANDBY mo*de. See note 2.*
2. In STANDBY mode, V_{LPVREG} is observed on the V_{18BKP} pin
   In STOP mode, V_{LPVREG} is observed on the V_{18}, V_{18REG} and V_{18BKP} pins.
3. Once V_{DD_IO} has reached 3.0 V, the RSM (Regulator Startup Monitor) generates an internal RESET during this start-up time.

Figure 16. Power consumption in STOP mode in Single supply scheme (3.3 V range)

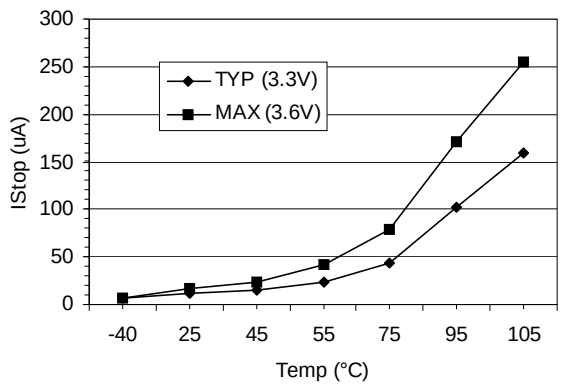


Figure 17. Power consumption in STOP mode Single supply scheme (5 V range)

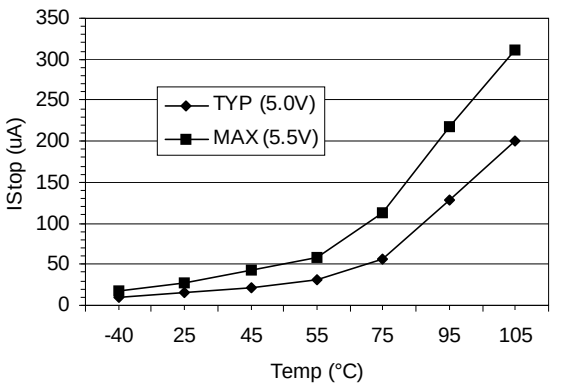


Figure 18. Power consumption in STANDBY mode (3.3 V range)

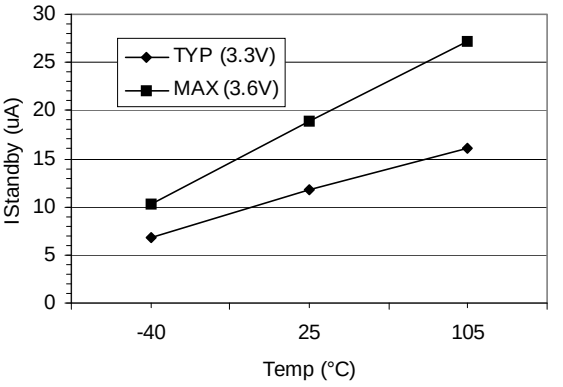
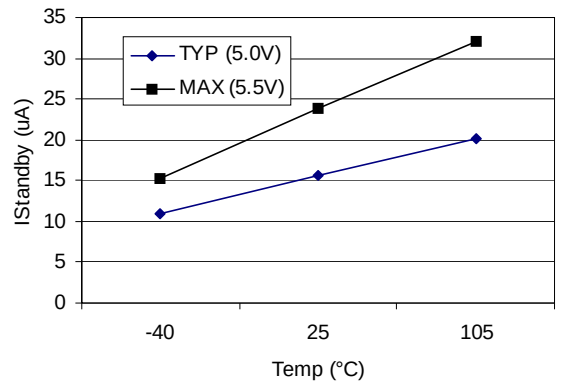


Figure 19. Power consumption in STANDBY mode (5 V range)



Subject to general operating conditions for V_{DD_IO}, and T_A

Table 15. Single supply typical power consumption in Run, WFI, Slow and Slow-WFI modes

Symbol	Para meter	Conditions	3.3V typ(1)	5V typ(2)	Unit
I_{DD} (3)	Supply current in RUN mode(4)	Clocked by OSC4M with PLL multiplication, all peripherals enabled in the MRCC_PLCKEN register: f_{HCLK}=60 MHz, f_{PCLK}=30 MHz f_{HCLK}=56 MHz, f_{PCLK}=28 MHz f_{HCLK}=48 MHz, f_{PCLK}=24 MHz f_{HCLK}=32 MHz, f_{PCLK}=32 MHz f_{HCLK}=16 MHz, f_{PCLK}=16 MHz f_{HCLK}=8 MHz, f_{PCLK}=8 MHz	 80 75 65 59 34 20	 82 77 67 61 37 22	mA
		Clocked by OSC4M with PLL multiplication, only EXTIT peripheral enabled in the MRCC_PLCKEN register: f_{HCLK}=60 MHz, f_{PCLK}=30 MHz f_{HCLK}=56 MHz, f_{PCLK}=28 MHz f_{HCLK}=48 MHz, f_{PCLK}=24 MHz f_{HCLK}=32 MHz, f_{PCLK}=32 MHz f_{HCLK}=16 MHz, f_{PCLK}=16 MHz f_{HCLK}=8 MHz, f_{PCLK}=8 MHz	 65 60 54 42 22 16	 67 62 55 44 24 18	mA
	Supply current in WFI mode(4)	Clocked by OSC4M with PLL multiplication, only EXTIT peripheral enabled in the MRCC_PLCKEN register: f_{HCLK}=60 MHz, f_{PCLK}=30 MHz(5) f_{HCLK}=56 MHz, f_{PCLK}=28 MHz(5) f_{HCLK}=48 MHz, f_{PCLK}=24 MHz(5) f_{HCLK}=32 MHz, f_{PCLK}=32 MHz(6) f_{HCLK}=16 MHz, f_{PCLK}= 16 MHz (6) f_{HCLK}= 8 MHz, f_{PCLK}= 8 MHz(6)	 62 59 53 22 13 10	 63 60 54 23 15 11	mA
	Supply current in SLOW mode(4)	Clocked by FREEOSC: f_{HCLK}=f_{PCLK}=~5 MHz, Clocked by OSC4M: f_{HCLK}=f_{PCLK}=4 MHz Clocked by LPOSC: f_{HCLK}=f_{PCLK}=~300 kHz Clocked by OSC32K: f_{HCLK}=f_{PCLK}=32.768 kHz	9 8 3.65 3.5	10 9 3.9 4.2	mA
	Supply current in SLOW-WFI mode(4)(7)	Clocked by FREEOSC: f_{HCLK}=f_{PCLK}=~5 MHz Clocked by OSC4M: f_{HCLK}=f_{PCLK}=4 MHz Clocked by LPOSC: f_{HCLK}=f_{PCLK}=~300 kHz Clocked by OSC32K: f_{HCLK}=f_{PCLK}=32.768 kHz	3.5 3.1 1.15 0.98	4.0 3.75 1.65 1.5	mA

1. Typical data based on T_A=25° C and V_{DD_IO}=3.3V.
2. Typical data based on T_A=25° C and V_{DD_IO}=5.0V.
3. The conditions for these consumption measurements are described at the beginning of *Section 6.3.4 on page 36*.
4. Single supply scheme see *Figure 14*.
5. Parameter setting BURST=1, WFI_FLASHEN=1
6. Parameter setting BURST=0, WFI_FLASHEN=0
7. Parameter setting WFI_FLASHEN=0, OSC4MOFF=1

On-Chip peripheral power consumption

Conditions:

- V_{DD_IO}=V_{DDA_ADC}=V_{DDA_PLL}=3.3 V or 5 V ±10% unless otherwise specified.
- T_A= 25° C
- Clocked by OSC4M with PLL multiplication, f_{CK_SYS}=64 MHz, f_{HCLK}=32 MHz, f_{PCLK}=32 MHz

Table 19. On-Chip peripherals

Symbol	Parameter	Typ (3.3V and 5.0V)	Unit
$I_{DD(TIM)}$	TIM Timer supply current (1)	0.7	mA
$I_{DD(PWM)}$	PWM Timer supply current(2)	1	
$I_{DD(SSP)}$	SSP supply current (3)	1.3	
$I_{DD(UART)}$	UART supply current (4)	1.6	
$I_{DD(I2C)}$	I2C supply current (5)	0.3	
$I_{DD(ADC)}$	ADC supply current when converting (6)	1.2	
$I_{DD(USB)}$	USB supply current (7) **Note:** V_{DD_IO} must be 3.3 V ±10%	0.90	
$I_{DD(CAN)}$	CAN supply current (8)	2.8	

1. Data based on a differential I_{DD} measurement between reset configuration and timer counter running at 32 MHz. No IC/OC programmed (no I/O pads toggling)
2. Data based on a differential I_{DD} measurement between reset configuration and PWM running at 32 MHz. This measurement does not include PWM pads toggling consumption.
3. Data based on a differential I_{DD} measurement between reset configuration and permanent SPI master communication at maximum speed 16 MHz. The data sent is 55h. This measurement does not include the pad toggling consumption.
4. Data based on a differential I_{DD} measurement between reset configuration and a permanent UART data transmit sequence at 1Mbauds. This measurement does not include the pad toggling consumption.
5. Data based on a differential I_{DD} measurement between reset configuration (I2C disabled) and a permanent I2C master communication at 100kHz (data sent equal to 55h). This measurement includes the pad toggling consumption but not the external 10kOhm external pull-up on clock and data lines.
6. Data based on a differential I_{DD} measurement between reset configuration and continuous A/D conversions at 8 MHz in scan mode on 16 inputs configured as AIN.
7. Data based on a differential I_{DD} measurement between reset configuration and a running generic HID application.
8. Data based on a differential IDD measurement between reset configuration (CAN disabled) and a permanent CAN data transmit sequence in loopback mode at 1MHz. This measurement does not include the pad toggling consumption.

XRTC1 external clock source

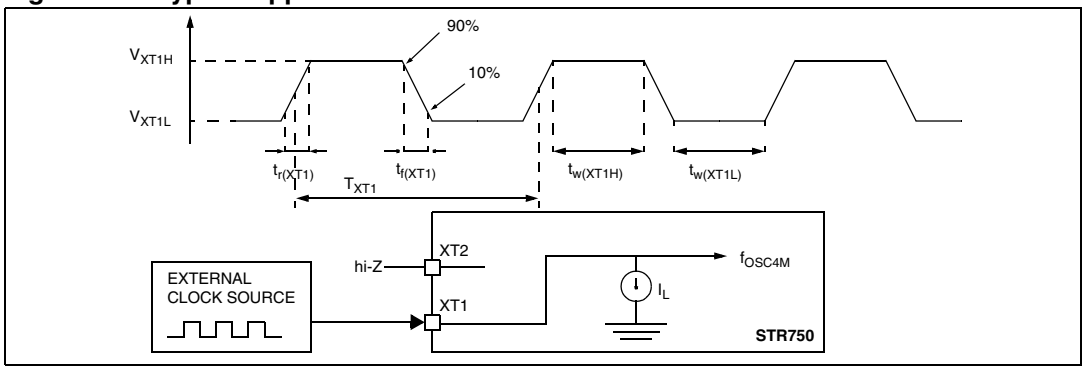
Subject to general operating conditions for V_{DD_IO}, and T_A.

Table 21. XRTC1 external clock source

Symbol	Parameter	Conditions(1)	Min	Typ	Max	Unit
f_{XRTC1}	External clock source frequency	see *Figure 20*		32.768	500	kHz
V_{XRTC1H}	XRTC1 input pin high level voltage		$0.7xV_{DD\_IO}$		V_{DD_IO}	V
V_{XRTC1L}	XRTC1 input pin low level voltage		V_{SS}		$0.3xV_{DD\_IO}$	
$t_{w(XRTC1H)}$ $t_{w(XRTC1L)}$	XRTC1 high or low time(2)		900			ns
$t_{r(XRTC1)}$ $t_{f(XRTC1)}$	XRTC1 rise or fall time(2)				50	
I_L	XRTCx Input leakage current	$V_{SS} \le V_{IN} \le V_{DD\_IO}$			±1	µA
$C_{IN(RTC1)}$	XRTC1 input capacitance(2)			5		pF
$DuCy_{(RTC1)}$	Duty cycle		30		70	%

1. Data based on typical application software.
2. Data based on design simulation and/or technology characteristics, not tested in production.

Figure 20. Typical application with an external clock source



6.3.9 TB and TIM timer characteristics

Subject to general operating conditions for V_{DD_IO}, f_{CK_SYS}, and T_A unless otherwise specified.

Refer to *Section 6.3.8: I/O port pin characteristics on page 54* for more details on the input/output alternate function characteristics (output compare, input capture, external clock, PWM output...).

Table 36. TB and TIM timers

Symbol	Parameter	Conditions		Min	Typ	Max	Unit
$t_{w(ICAP)in}$	Input capture pulse time	TIM0,1,2		2			t_{CK_TIM}
$t_{res(TIM)}$	Timer resolution time(1)	TB	$f_{CK\_TIM(MAX)} = f_{CK\_SYS}$	1			t_{CK_TIM}
			$f_{CK\_TIM} = f_{CK\_SYS}$ = 60 MHz	16.6(1)			ns
		TIM0,1,2	$f_{CK\_TIM(MAX)} = f_{CK\_SYS}$	1			t_{CK_TIM}
			$f_{CK\_TIM} = f_{CK\_SYS}$ = 60MHz	16.6(1)			ns
f_{EXT}	Timer external clock frequency on TI1 or TI2	TIM0,1,2	$f_{CK\_TIM(MAX)} = f_{CK\_SYS}$	0		$f_{CK\_TIM}/4$	MHz
			$f_{CK\_TIM} = f_{CK\_SYS}$ = 60 MHz	0		15	MHz
Res_{TIM}	Timer resolution					16	bit
$t_{COUNTER}$	16-bit Counter clock period when internal clock is selected (16-bit Prescaler)	TB		1		65536	t_{CK_TIM}
			$f_{CK\_TIM} = f_{CK\_SYS}$ = 60 MHz	0.0166		1092	µs
		TIM0,1,2		1		65536	t_{CK_TIM}
			$f_{CK\_TIM} = f_{CK\_SYS}$ = 60 MHz	0.0166		1092	µs
t_{MAX_COUNT}	Maximum Possible Count	TB				65536x65536	t_{CK_TIM}
			$f_{CK\_TIM} = f_{CK\_SYS}$ = 60 MHz			71.58	s
		TIM0,1,2				65536x65536	t_{CK_TIM}
			$f_{CK\_TIM} = f_{CK\_SYS}$ = 60 MHz			71.58	s

1. Take into account the frequency limitation due to the I/O speed capability when outputting the PWM to I/O pin, described in *: Output speed on page 57*.

Figure 37. TI configuration - slave mode, single transfer

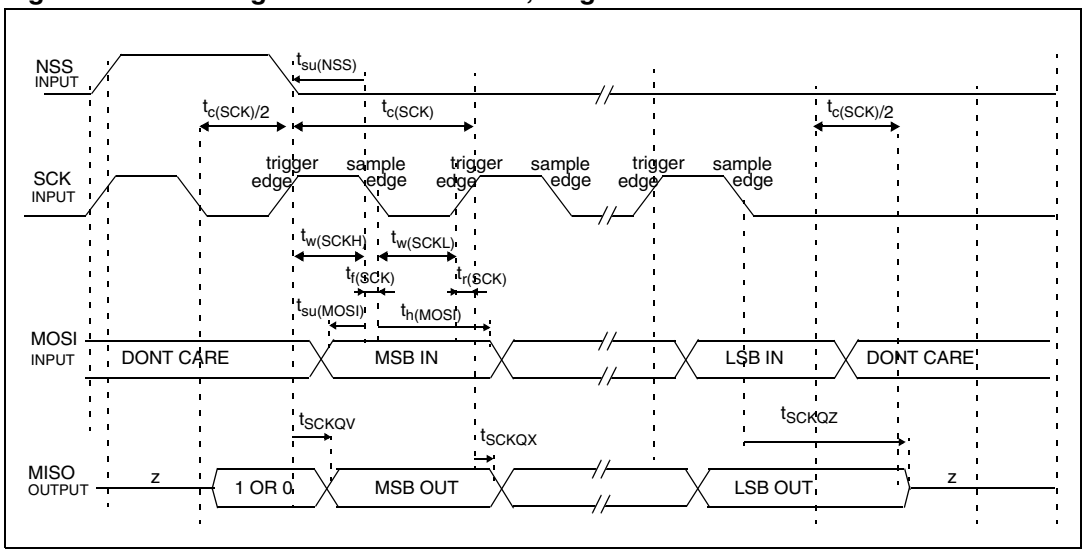
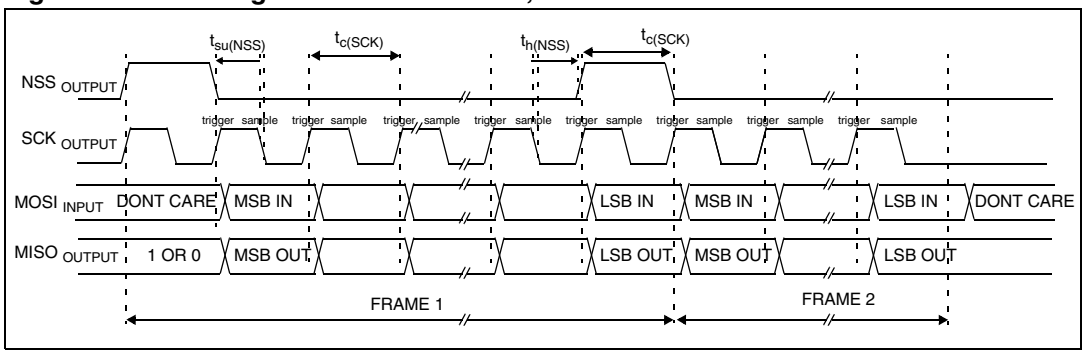


Figure 38. TI configuration - slave mode, continuous transfer



not possible to power off the STR7x while some another I^2C master node remains powered on: otherwise, the STR7x will be powered by the protection diode.

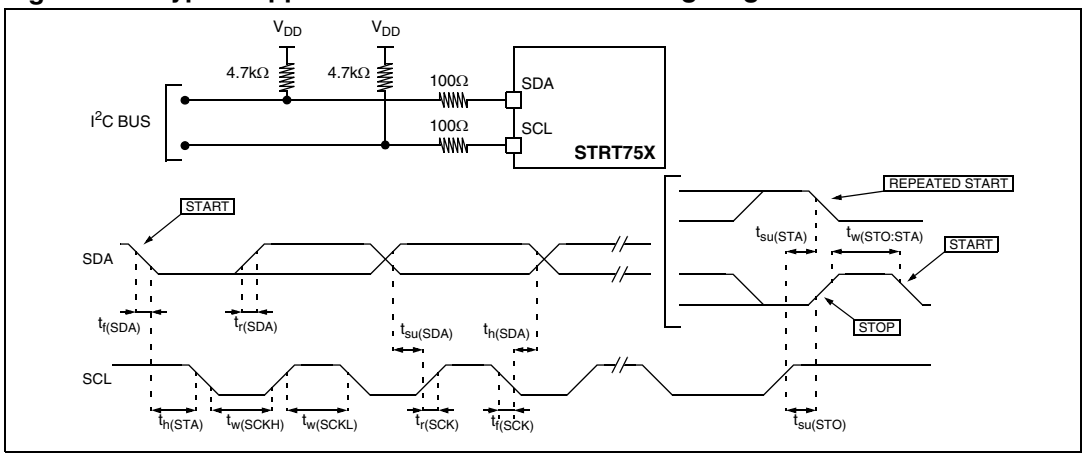
Refer to I/O port characteristics for more details on the input/output alternate function characteristics (SDA and SCL).

Table 41. SDA and SCL characteristics

Symbol	Parameter	Standard mode I^2C		Fast mode I^2C(1)		Unit
		Min(2)	Max(2)	Min(2)	Max(2)	
$t_{w(SCLL)}$	SCL clock low time	4.7		1.3		µs
$t_{w(SCLH)}$	SCL clock high time	4.0		0.6		µs
$t_{su(SDA)}$	SDA setup time	250		100		ns
$t_{h(SDA)}$	SDA data hold time	0(3)		0(4)	900(3)	ns
$t_{r(SDA)}$ $t_{r(SCL)}$	SDA and SCL rise time		1000	20+0.1C_b	300	ns
$t_{f(SDA)}$ $t_{f(SCL)}$	SDA and SCL fall time		300	20+0.1C_b	300	ns
$t_{h(STA)}$	START condition hold time	4.0		0.6		µs
$t_{su(STA)}$	Repeated START condition setup time	4.7		0.6		µs
$t_{su(STO)}$	STOP condition setup time	4.0		0.6		µs
$t_{w(STO:STA)}$	STOP to START condition time (bus free)	4.7		1.3		µs
C_b	Capacitive load for each bus line		400		400	pF

1. f_{PCLK}, must be at least 8 MHz to achieve max fast I^2C speed (400 kHz).
2. Data based on standard I^2C protocol requirement, not tested in production.
3. The maximum hold time $t_{h(SDA)}$ is not applicable
4. The device must internally provide a hold time of at least 300 ns for the SDA signal in order to bridge the undefined region of the falling edge of SCL.

Figure 40. Typical application with I^2C bus and timing diagram



1. Measurement points are done at CMOS levels: 0.3xV_{DD} and 0.7xV_{DD}.

7.2 Thermal characteristics

The maximum chip junction temperature (T_{Jmax}) must never exceed the values given in *Table 10: General operating conditions on page 34*.

The maximum chip-junction temperature, T_{Jmax}, in degrees Celsius, may be calculated using the following equation:

$$T_{Jmax} = T_{Amax} + (P_{Dmax} \times \Theta_{JA})$$

Where:

- T_{Amax} is the maximum Ambient Temperature in °C,
- Θ_{JA} is the Package Junction-to-Ambient Thermal Resistance, in ° C/W,
- P_{Dmax} is the sum of P_{INTmax} and $P_{I/Omax}$ ($P_{Dmax} = P_{INTmax} + P_{I/Omax}$),
- P_{INTmax} is the product of I_{DD} and V_{DD}, expressed in Watts. This is the maximum chip internal power.
- $P_{I/Omax}$ represents the maximum Power Dissipation on Output Pins.
  Where:
  $P_{I/Omax} = \Sigma (V_{OL}*I_{OL}) + \Sigma((V_{DD}-V_{OH})*I_{OH})$,
  taking into account the actual V_{OL} / I_{OL} and V_{OH} / I_{OH} of the I/Os at low and high level in the application.

Table 48. Thermal characteristics(1)

Symbol	Parameter	Value	Unit
Θ_{JA}	**Thermal Resistance Junction-Ambient** LQFP 100 - 14 x 14 mm / 0.5 mm pitch	46	°C/W
Θ_{JA}	**Thermal Resistance Junction-Ambient** LQFP 64 - 10 x 10 mm / 0.5 mm pitch	45	°C/W
Θ_{JA}	**Thermal Resistance Junction-Ambient** LFBGA 64 - 8 x 8 x 1.7mm	58	°C/W
Θ_{JA}	**Thermal Resistance Junction-Ambient** LFBGA 100 - 10 x 10 x 1.7mm	41	°C/W

1. Thermal resistances are based on JEDEC JESD51-2 with 4-layer PCB in a natural convection environment.

7.2.1 Reference document

JESD51-2 Integrated Circuits Thermal Test Method Environment Conditions - Natural Convection (Still Air). Available from www.jedec.org